

# Zinc Tin Oxide as High-Temperature Stable Recombination Layer for Mesoscopic Perovskite/Silicon Monolithic Tandem Solar Cells

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Perovskite/crystalline silicon tandem solar cells have the potential to reach efficiencies beyond those of silicon single-junction record devices. However, the high-temperature process of 500°C needed for state-of-the-art mesoscopic perovskite cells has, so far, been limiting their implementation in monolithic tandem devices. Here, we demonstrate the applicability of zinc tin oxide as recombination layer and show its electrical and optical stability at temperature up to 500°C. To prove the concept, we fabricate monolithic tandem cells with mesoscopic top cell with up to 16% efficiency. We then investigate the effect of zinc tin oxide thickness variation, showing a strong influence on the optical interference pattern within the tandem device. Finally, we discuss the perspective of mesoscopic perovskite cells for high-efficiency monolithic tandem solar cells.

Perovskite solar cells have made tremendous progress in a very short time, reaching now initial efficiencies above 22%.<sup>1</sup> In parallel to the single-junction development, perovskite materials were shown to have excellent properties for tandem applications, allowing for rapid advances, such that efficiencies beyond 20% on both monolithic and 4-terminal tandem architectures have already been reached,<sup>2-5</sup> with reported record 4 terminal measurements of 25.2%.<sup>5</sup>

So far, the research focused mainly on silicon heterojunction bottom cells,<sup>3-5</sup> as these devices combine record operating voltages with an excellent infrared response, and ease of contacting with a full TCO coverage on both sides of the device. However, due to their sensitivity to process temperature above 200-300°C,<sup>6</sup> this type of bottom cell is not compatible with high-efficiency mesoscopic perovskite top cells. Indeed, this perovskite cell architecture, which is at the origin of all recent single-junction efficiency certified records,<sup>1,7-9</sup> is commonly based on a mesoporous TiO<sub>2</sub> scaffold layer, which typically requires a 500°C annealing step, prior to perovskite absorber deposition. Most diffused silicon solar cells could be designed to be compatible with a 500°C step, as they undergo typical diffusion/oxidation or firing steps close to 900°C.

Incorporating this type of perovskite cell in a monolithic tandem therefore requires both silicon bottom cell and intermediate recombination layer to be stable up to a temperature of 500°C. Typical additional requirements for an efficient intermediate recombination layer are correct band energetics to guarantee efficient interband tunneling with the underlying silicon device, high optical transparency (especially between 600nm and 1200nm), as well as chemical stability and process simplicity.

Mailoa *et al.* demonstrated the use of a partially crystalline  $n^{++} a\text{-Si} / p^{++} c\text{-Si}$  tunnel junction made by plasma-enhanced chemical vapor deposition, which required a very careful control of the deposition conditions and post-

deposition annealing.<sup>2</sup> In contrast, transparent conducting oxides (TCOs) have already proven their simplicity of application and effectiveness as recombination layers in monolithic tandem solar cells.<sup>3-5</sup> However, the commonly used indium tin oxide (ITO) or indium zinc oxide (IZO) are neither electrically nor optically stable upon annealing in oxygen containing environment at 500°C, and therefore are not compatible with the mesoscopic perovskite top cell fabrication procedure.

Here, we present a simple method to tandem a mesoscopic perovskite top cell with a homojunction silicon bottom cell, using a sputtered zinc tin oxide (ZTO) recombination layer. ZTO has previously been used as an electron transport layer in organic optoelectronic devices<sup>10,11</sup> and in thin-film transistors as the channel material.<sup>12,13</sup> It was shown to be a promising indium-free  $n$ -type metal oxide with high electron mobility and transparency, as well as good temperature stability and mechanical integrity.<sup>14</sup> These properties qualify ZTO as an attractive candidate for the integration in monolithic tandem devices as an intermediate

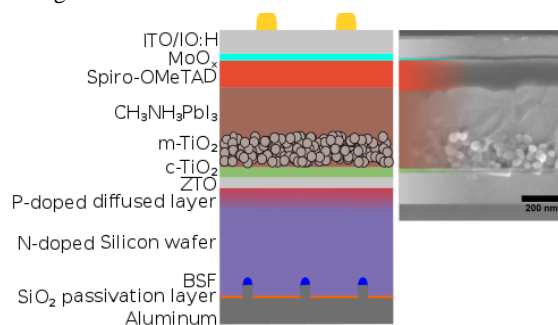


Figure 1 Monolithic tandem cell structure with mesoscopic perovskite top cell and homojunction silicon bottom cell. The SEM image shows a cross-section of a typical perovskite top cell. (BSF=Back Surface Field;  $m\text{-TiO}_2$  = scaffold layer;  $c\text{-TiO}_2$  = compact electron transport layer; Spiro-OMeTAD = hole transport layer)

recombination layer. In this article, we demonstrate the thermal stability of optical and electrical properties up to 500°C, suggesting that it can indeed be used effectively in a tandem solar cell as recombination layer. As a proof-of-principle, we fabricated monolithic tandem cells with efficiencies up to 16%, with an aperture area of 1.43 cm<sup>2</sup>. Finally, we experimentally show how the variation of the recombination layer thickness influences the optical interference pattern in the device.

Bottom cell fabrication started with electrical junction formation in *n*-type silicon wafers. For this, silicon oxide layers were thermally grown on both wafer surfaces. The active device area was then defined by removing the oxide on the front side of the Si wafers, followed by boron implantation, forming thus a hole-collecting emitter. On the rear side, the surface-passivating silicon oxide layer was laser-patterned and phosphorus implanted for local contact and back surface field formation. We remark that the used wafers featured mirror-polished front sides (and a lapped back side), to avoid shunting of the solution processed top cell. To ensure the absence of a native SiO<sub>2</sub> layer, we performed a HF dip before the TCO (ITO or ZTO) was directly sputtered onto the boron-implanted silicon surface, followed by the perovskite top cell deposition. The top cell was composed of a sputtered compact TiO<sub>2</sub> layer (c-TiO<sub>2</sub>), a TiO<sub>2</sub> scaffold layer (m-TiO<sub>2</sub>) annealed at 500°C, a CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub> perovskite layer and a spiro-OMeTAD/MoO<sub>3</sub>/IO:H/ITO top electrode, as described in more details in supplementary information and illustrated in Figure 1.

As ITO is one of the most commonly used TCOs in photovoltaics, it was naturally our initial choice for the intermediate recombination layer. However, strong degradation could be observed on finished monolithic tandem cells with poor current-voltage (*J-V*) characteristics, similar to the example shown in Figure 2a. Electrical characterization of the ITO layers on glass before and after annealing at 500°C showed a strong reduction in carrier density, which is attributed to a filling of the oxygen deficiencies, by oxygen diffusion from the air or from the capping TiO<sub>2</sub> layer. Consequently, a massive drop in conductivity from initially 2207 (Ωcm)<sup>-1</sup> (mobility: 36.8 cm<sup>2</sup>/Vs; carrier concentration: 3.7x10<sup>20</sup> cm<sup>-3</sup>; see Figure S6) could be observed, making the films essentially non-measurable with our Hall-effect setup after the complete annealing sequence. The strongly increased resistance in this recombination layer is believed to be responsible for the non-functional tandem devices.

In contrast, ZTO showed an improvement in the electrical and optical properties upon annealing at 500°C in air, as presented in Figure 3. After annealing, the film showed an improved total transmittance, up to 85% at a wavelength of 800 nm. The electrical properties were also enhanced, resulting in an increase in the Hall effect electron mobility from 21.8 to 35 cm<sup>2</sup>V<sup>-1</sup>s<sup>-1</sup> and an improvement in conductivity from 283 to 433 (Ωcm)<sup>-1</sup>, for 150-nm-thick layers on glass substrates. These properties are sufficient to ensure good transverse charge transport through a recombination junction.

We then applied this material in monolithic tandem solar cells as the intermediate recombination layer and investigated the effect of thickness variation from 20 nm to

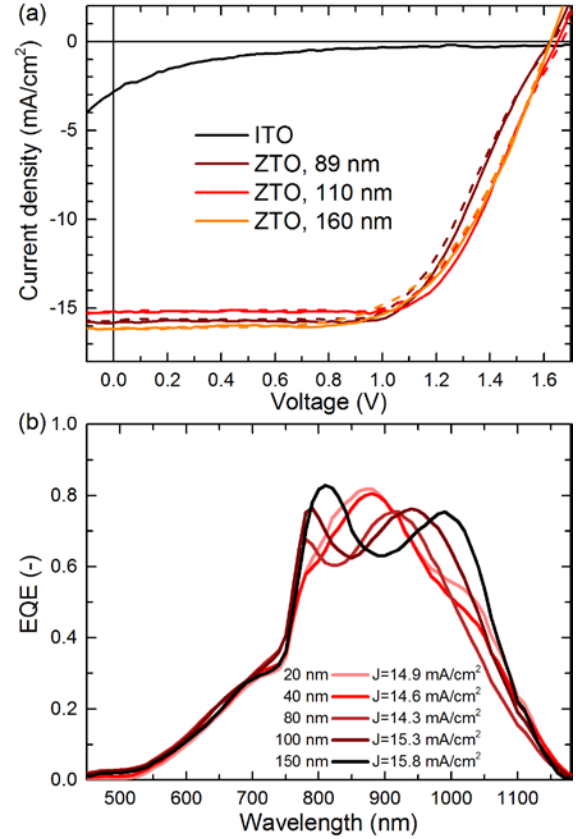


Figure 2 a) *J-V* curves of monolithic tandem cells with ITO or ZTO recombination layer. Dashed lines are for forward scans ( $J_{sc}$  to  $V_{oc}$ ) and solid lines are for reverse scan ( $V_{oc}$  to  $J_{sc}$ ); b) EQE curves of bottom cells in monolithic tandem devices with different ZTO recombination layer thicknesses.

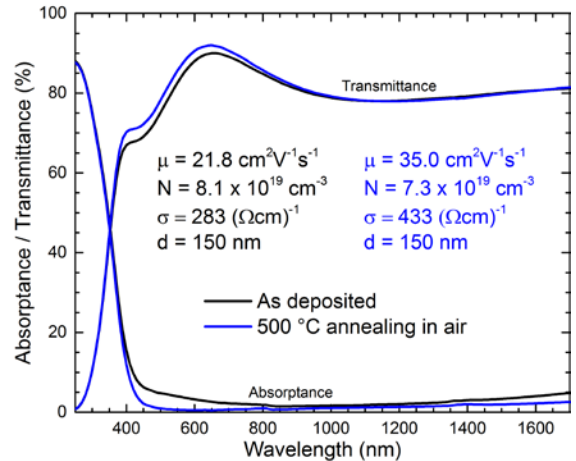


Figure 3 UV-vis-NIR spectrophotometric measurements showing the transmittance and absorbance of a 150 nm thick ZTO layer on glass before and after annealing at 500°C in air. Hall Effect characteristics are also given.  $\mu$ =mobility;  $N$ =carrier density;  $\sigma$ =conductivity;  $d$ =thickness.

160 nm. The resulting  $J$ - $V$  and external quantum efficiency (EQE) characteristics are given in Figure 2, showing rectifying diode-like curves, in contrast to the series resistance limited ITO-based tandem cells. The  $J$ - $V$  curves with thinner ZTO layers were slightly s-shaped around  $V_{oc}$ . However, this problem disappeared with thicker layers, as shown in Figure 2a.

150 Interestingly, the thickness of this recombination layer had a strong effect on the optical interference pattern in the bottom cell, as revealed by EQE measurements shown in Figure 2b. In our previous study on planar perovskite/silicon monolithic tandem cells,<sup>4</sup> the recombination layer thickness did not have such a pronounced interference effect. However, the presence of a mesoscopic layer was found not to be the reason for this difference, as shown in Figure S1 with scaffold-free tandem cells featuring similar interference pattern modifications with thickness. We believe the origin of this phenomenon is found in the different refractive indices of the electron transporting layer (ETL): in our present study, we use TiO<sub>2</sub> which has a refractive index of ~2.5 at 800 nm, compared to 1.9 for the fullerene-based ETL used previously.<sup>4</sup> TCOs such as IZO<sup>15</sup> or ZTO (Figure S2) have refractive indices of about 2 and are therefore better

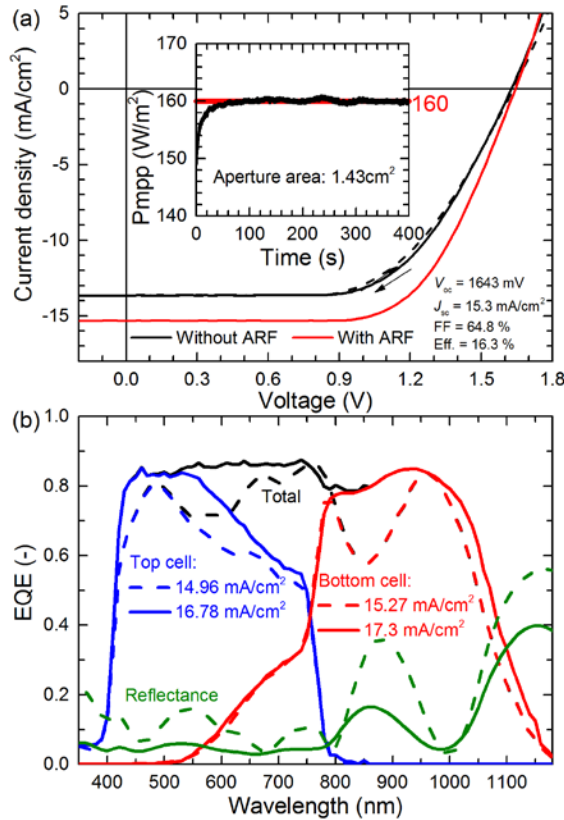


Figure 4 a)  $J$ - $V$  measurements of the best performing  $>1$  cm<sup>2</sup> monolithic tandem with and without antireflective foil (ARF). The inset shows the steady power output measured under maximum power point tracking; b) EQE and total reflectance measurements of the same device as in a), with (solid lines) and without (dashed lines) ARF. The total curve is the sum of the top and bottom cell responses.

matched to that of the fullerene than TiO<sub>2</sub>, as shown in Figure S1b. The larger index contrasts between the intermediate recombination layer and the ETL might therefore be the origin of strong internal reflections at this interface (shown in Figure S3), resulting in the importance of the recombination layer thickness in the overall device optics. Advanced optical modelling would be necessary to further study the interplay of these layers and fine-tune their properties.

In this study, the best monolithic tandem cell with an aperture area of 1.43 cm<sup>2</sup> showed a  $V_{oc}$  of 1643 mV and an initial efficiency of 16.3%, as obtained from  $J$ - $V$  characteristics, as shown in Figure 4a. During maximum power point tracking, a steady efficiency of 16% was reached (inset to Figure 4a). A smaller cell of 0.25 cm<sup>2</sup> reached 17.4% (16.4% steady-state; Figure S4). The single-junction semitransparent perovskite solar cells processed as references together with the tandem devices had modest efficiencies around 12% with  $V_{oc}$  values of ~1000 mV (Figure S5). The silicon bottom cells  $V_{oc}$  has been estimated from devices simulations using Quokka<sup>16</sup> to be around 640 mV. Therefore, the  $V_{oc}$  of the tandem was close to the sum of the individual  $V_{oc}$  values of the subcells. Clear potential for  $V_{oc}$  improvement can be foreseen when comparing the two subcells performances to their state-of-the-art references in literature.<sup>6,8</sup> A boost in  $V_{oc}$  of 100-150 mV for the perovskite cell and 50-100 mV for silicon cells with passivated full area contacts could be expected.

The tandem overall performance was mostly limited by series resistance, reducing the fill factor. Further optimization will be required to reduce interfacial resistances in the device, by a better control on the charge carrier density in the recombination layer, and better rear contact processing.

Figure 4b shows the EQE curves for the best large area tandem cell, confirming a closely matched top and bottom cell current generation. The device is however still largely limited by reflection and parasitic absorption, similarly to previous reports.<sup>3-5</sup> Parasitic absorption losses are nevertheless much less prominent compared to the previous work on mesoscopic monolithic tandem cells by Mailoa *et al.*,<sup>2</sup> resulting in a largely improved current. The top cell current is however still limited by absorption in the spiro-OMeTAD hole transporting layer strongly at wavelength  $< 400$  nm. This recurrent problem in this device configuration is an important issue to be solved in the future to further improve current generation in the top cell.<sup>4</sup> The bottom cell could be optically improved by introducing a rear-side texture, in order to increase the near-infrared spectral response.<sup>5</sup>

The tandem process demonstrated here could be applied to higher efficiency silicon bottom cell including standard solar cells made by the diffusion/firing process. In such a case, openings should be made in the SiN of the c-Si cells to contact the doped region. Another more ideal approach would be the use of temperature stable fully passivated contacts.<sup>17</sup> This type of device could rapidly becoming a mainstream high-efficiency silicon commercial technology.<sup>18</sup> Combined with a record top cell,<sup>8,19</sup> monolithic tandem cells could be manufactured at low cost using simple fabrication processes, and performance up to 30% should be practically feasible.<sup>20,21</sup>

To conclude, we have demonstrated the applicability of ZTO as a high-temperature-stable recombination layer, by electro-optical characterization and integration to fully functional devices. This simple junction allowed us to fabricate mesoscopic perovskite/silicon homojunction monolithic tandem solar cells with >16% efficiency. A systematic analysis of the ZTO layer thickness revealed strong resonance effects due to refractive index mismatch with the electron contact and allowed the optimization of the recombination layer thickness for best electrical and optical performance. Further development on the perovskite absorber composition, hole transporting layer transparency and silicon surfaces passivation is expected to result in improved overall performance, with the potential for >30%.

## 245 Supplementary material

See supplementary material for the experimental details on device fabrication and characterization, ellipsometric and reflectance data and smaller tandem device performance.

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